



MPS
2333
STATIC READ
ONLY MEMORY
(4096x8)

2333 STATIC READ ONLY MEMORY (4096x8)

DESCRIPTION

The 2333 high performance read only memory is organized 4096 words by 8 bits with access times of less than 350 ns. This ROM is designed to be compatible with all microprocessor and similar applications where high performance, large bit storage and simple interfacing are important design considerations. This device offers TTL input and output levels.

The 2333 operates totally asynchronously. No clock input is required. The two programmable chip select inputs allow four 32K ROMS to be OR-tied without external decoding.

Designed to replace two 2716 16K EPROMS, the 2333 can eliminate the need to redesign printed circuit boards for volume mask programmed ROMS after prototyping with EPROMS.

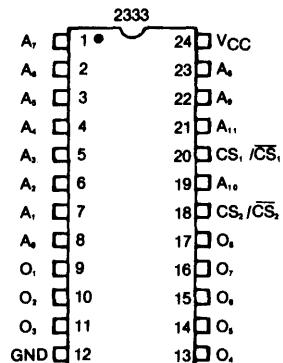
- 4096 x 8 Bit Organization
- Single +5 Volt Supply
- Three Week Prototype Turnaround
- Access Time—2333 450 ns
2333A 350 ns
- Completely TTL Compatible
- Totally Static Operation
- Three-State Outputs for Wire-OR Expansion
- Two Programmable Chip Selects
- Pin Compatible with 2716 & 2732 (INTEL) EPROMS
- Replacement for Two 2716s
- 2708/2716 EPROMS Accepted as Program Data Inputs
- 400 mV Noise Immunity on Inputs

ORDERING INFORMATION:

| Part Number* | Package Type | Access Time | Temperature Range |
|--------------|--------------|-------------|-------------------|
| MPS2333 | Molded | 450 ns | 0°C to +70°C |
| MPS2333A | Molded | 350 ns | 0°C to +70°C |
| MCS2333 | Ceramic | 450 ns | 0°C to +70°C |
| MCS2333A | Ceramic | 350 ns | 0°C to +70°C |

*Final Part Number will be assigned by manufacturer

PIN CONFIGURATION





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2333**ABSOLUTE MAXIMUM RATINGS**

| | |
|------------------------------------|-----------------|
| Ambient Operating Temperature | 0° to +70°C |
| Storage Temperature | -65°C to +150°C |
| Supply Voltage to Ground Potential | -0.5V to +7.0V |
| Applied Output Voltage | -0.5V to +7.0V |
| Applied Input Voltage | -0.5V to +7.0V |
| Power Dissipation | 1.0W |

COMMENT

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

D.C. CHARACTERISTICS

T_A = 0°C to +70°C, V_{CC} = 5.0V ±5% (unless otherwise specified)

| Symbol | Parameter | Min. | Max. | Units | Test Conditions |
|------------------|------------------------|------|--------------------|-------|--|
| I _{CC1} | Power Supply Current | | 125 | mA | V _{IN} = V _{CC} , V _O = Open, T _A = 0 C |
| I _{CC2} | Power Supply Current | | 120 | mA | V _{IN} = V _{CC} , V _O = Open, T _A = 25 C |
| I _O | Output Leakage Current | | 10 | μA | Chip Deselected, V _O = 0 to V _{CC} |
| I _I | Input Load Current | | 10 | μA | V _{CC} = Max. V _{IN} = 0 to V _{CC} |
| V _{OL} | Output Low Voltage | | 0.4 | Volts | V _{CC} = Min. I _{OL} = 2.1mA |
| V _{OH} | Output High Voltage | 2.4 | | Volts | V _{CC} = Min. I _{OH} = -400μA |
| V _{IL} | Input Low Voltage | -0.5 | 0.8 | Volts | |
| V _{IH} | Input High Voltage | 2.0 | V _{CC} +1 | Volts | See note 1 |

A. C. CHARACTERISTICS

T_A = 0°C to +70°C, V_{CC} = 5.0V ±5% (unless otherwise specified)

| Symbol | Parameter | 2333 | | 2333A | | Units | Test Conditions |
|------------------|--|------|------|-------|------|-------|-----------------|
| | | Min. | Max. | Min. | Max. | | |
| t _{ACC} | Address Access Time | | 450 | | 350 | ns | |
| t _{CO} | Chip Select Delay | | 200 | | 200 | ns | |
| t _{DF} | Chip Deselect Delay | | 175 | | 175 | ns | |
| t _{OH} | Previous Data Valid After Address Change Delay | 40 | | 40 | | ns | See Note 2 |

CAPACITANCE

T_A = 25°C, f = 1.0MHz, See Note 3

| Symbol | Parameter | Min. | Max. | Units | Test Conditions |
|------------------|--------------------|------|------|-------|--|
| C _{IN} | Input Capacitance | | 8 | pF | |
| C _{OUT} | Output Capacitance | | 10 | pF | All Pins except Pin under Test Tied to AC Ground |

Note 1: Input levels that swing more negative than -0.5V will be clamped and may cause damage to the device.

Note 2: Loading 1 TTL + 100 pF, input transition time: 20 ns.

Timing measurement levels: input 1.5V, output 0.8V and 2.0V. C_L = 100 pF.

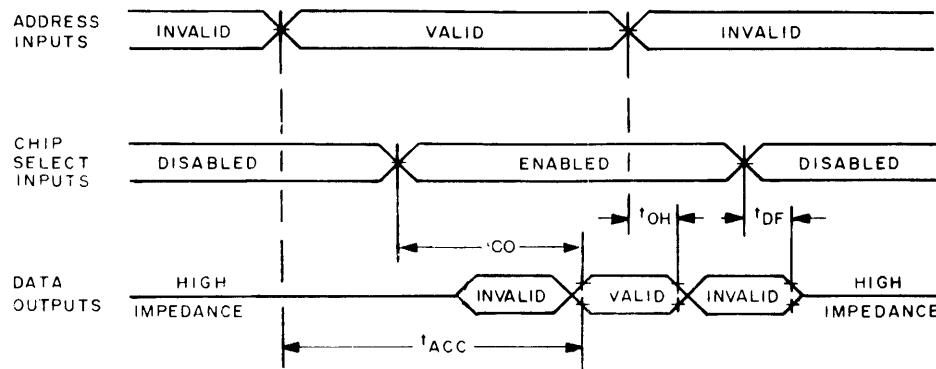
Note 3: This parameter is periodically sampled and is not 100% tested.



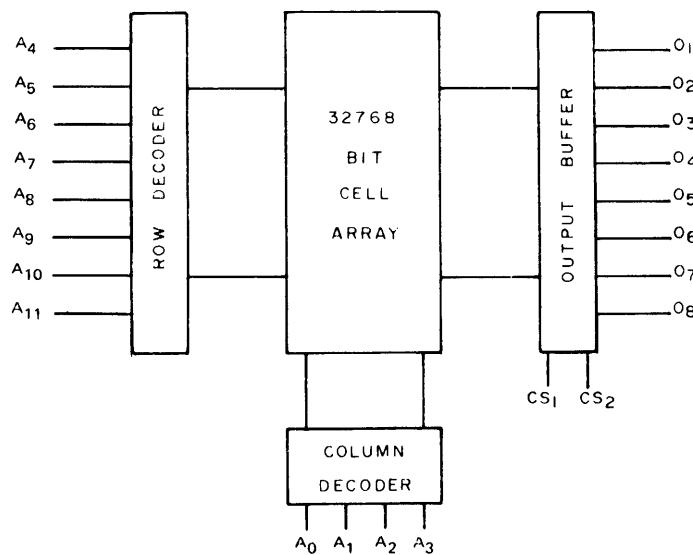
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TIMING DIAGRAM



BLOCK DIAGRAM

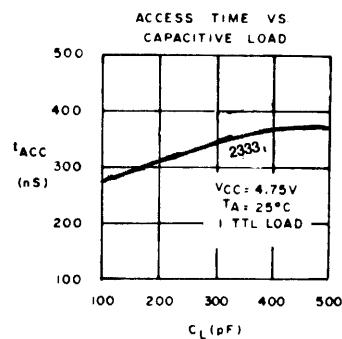
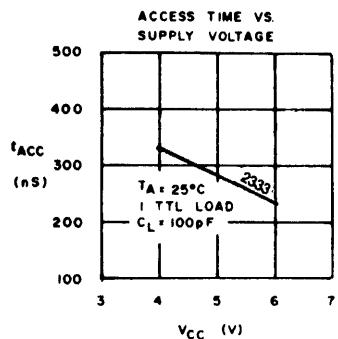




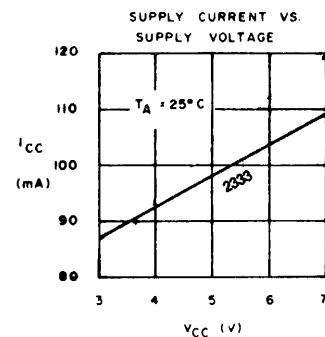
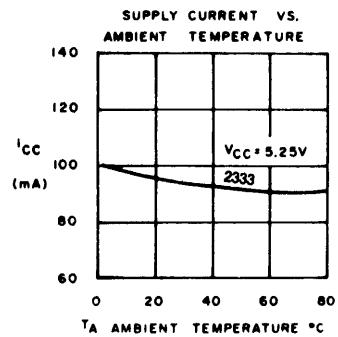
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TYPICAL CHARACTERISTICS



ROWS



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